

Application/Control No.	Applicant(s)/Patent ur Reexamination	nder
10/757,789	ARMSTRONG ET AL	
Examiner	Art Unit	
Christopher B. Shin	2181	

SEARCHED							
Subclass	Date	Examiner					
2, 8-19, 36-43, 104-105, 187	7/18/2006	CBS					
316-317	7/18/2006	CBS					
351-379	7/18/06	CBS					
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	Subclass 2, 8-19, 36-43, 104-105, 187 316-317	Subclass Date 2, 8-19, 36-43, 104-105, 187 316-317 7/18/2006					

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
710	38, 316	11/6/2006	cs		
370	359	11/6/2006	cs		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
PLUS	7/17/2006	CBS		
PALM (Double Patenting, Inventorship)	7/17/2006	CBS		
EAST (uspat, jpo, epo, derwent, ibmtdb, usocr)	7/17/2006	CBS		
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